

Search Notes

Application/Control No.

10/821,897

Examiner

David M. Fenstermacher

Applicant(s)/Patent under
Reexamination

OKOSHI, HIDEO

Art Unit

3682

SEARCHED

Class	Subclass	Date	Examiner
475	166		
	168		
	195		
476	61		
	65		
	67		
	33	6/7/2007	DMF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR